

C3M0040120J1

Silicon Carbide Power MOSFET C3M™ MOSFET Technology N-Channel Enchancement Mode

Features

- 3rd generation SiC MOSFET technology
- · Optimized package with separate driver source pin
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q,,)
- Halogen free, RoHS compliant

Benefits

- Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Reduce cooling requirements
- Increase power density
- · Increase system switching frequency

Applications

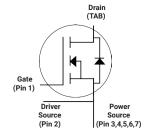
- Datacenter and Telecom Power Supplies
- EV Battery Chargers
- High voltage DC/DC converters
- Energy Storage Systems
- Solar Inverters

Package









Part Number	Package	Marking
C3M0040120J1	TO-263-7L XL	C3M0040120J1

Maximum Ratings (T_c = 25 °C unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note	
V _{DSmax}	Drain - Source Voltage	1200	٧	V _{GS} = 0 V, I _D = 100 μA		
V_{GSmax}	Gate - Source Voltage (dynamic)	-8/+19	٧	AC (f >1 Hz)	Note 1	
V_{GSop}	Gate - Source Voltage (static)	-4/+15	٧	Static	Note 2	
	Continuous Drain Current	64	А	$V_{GS} = 15 \text{ V}, T_{C} = 25^{\circ}\text{C}$	Fig. 19	
I _D	Continuous Diain Curient	42		$V_{GS} = 15 \text{ V}, T_{C} = 100^{\circ}\text{C}$		
I _{D(pulse)}	Pulsed Drain Current	100	А	Pulse width t _P limited by T _{jmax}		
P _D	Power Dissipation	272	W	T _c =25°C, T _J = 150 °C	Fig. 20	
T_{J} , T_{stg}	Operating Junction and Storage Temperature	-40 to +150	°C			
T _L	Solder Temperature	260	°C	1.6mm (0.063") from case for 10s		

Note (1): When using MOSFET Body Diode $V_{GSmax} = -4V/+19V$

Note (2): MOSFET can also safely operate at 0/+15 V



Electrical Characteristics (T_c = 25°C unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	Note	
V _{(BR)DSS}	Drain-Source Breakdown Voltage	1200			٧	V _{GS} = 0 V, I _D = 100 μA		
	Octo Through ald Walks are	1.8	2.7	3.6	٧	V _{DS} = V _{GS} , I _D = 9.2 mA		
$V_{\text{GS(th)}}$	Gate Threshold Voltage		2.2		٧	V _{DS} = V _{GS} , I _D = 9.2 mA, T _J = 150°C	Fig. 11	
I _{DSS}	Zero Gate Voltage Drain Current		1	50	μΑ	V _{DS} = 1200 V, V _{GS} = 0 V		
I_{GSS}	Gate-Source Leakage Current		10	250	nA	$V_{GS} = 15 \text{ V, } V_{DS} = 0 \text{ V}$		
P. Drain Source On State Resistance	Drain-Source On-State Resistance		40	53.5	mΩ	$V_{GS} = 15 \text{ V, } I_D = 33.3 \text{ A}$	Fig. 4,	
R _{DS(on)}	Drain-Source Off-State Resistance		60		11122	V _{GS} = 15 V, I _D = 33.3 A, T _J = 150°C	5, 6	
g _{fs} Transconductance		21		S	V _{DS} = 20 V, I _{DS} = 33.3 A	Fig. 7		
g _{fs}	Transconductance		20			V _{DS} = 20 V, I _{DS} = 33.3 A, T _J = 150°C	Fig. /	
C_{iss}	Input Capacitance		2900					
Coss	Output Capacitance		103		$V_{GS} = 0 \text{ V}, V_{DS} = 1000 \text{ V}$ $V_{GS} = 1000 \text{ V}$		Fig. 17,	
C_{rss}	Reverse Transfer Capacitance		5			V _{AC} = 25 mV		
E _{oss}	Coss Stored Energy		60		μJ		Fig. 16	
Eon	Turn-On Switching Energy (Body Diode FWD)		339			V _{DS} = 800 V, V _{GS} = -4 V/+15 V,		
E _{OFF}	Turn Off Switching Energy (Body Diode FWD)		67		μJ	$I_{D} = 33.3 \text{ A},$ $R_{G(ext)} = 2.5\Omega, L = 99 \mu\text{H},$	Fig. 26	
t _{d(on)}	Turn-On Delay Time		13				Fig. 27	
t _r	Rise Time		18		ns	$V_{DD} = 800 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}$ $R_{G(ext)} = 2.5 \Omega, I_D = 33.3 \text{ A}, L = 99$		
t _{d(off)}	Turn-Off Delay Time		22		1115	Timing relative to $V_{DS'}$ Inductive load		
t _f	Fall Time		8			ns,		
R _{G(int)}	Internal Gate Resistance		3.5		Ω	f = 1 MHz, V _{AC} = 25 mV		
Q_{gs}	Gate to Source Charge		35			V _{DS} = 800 V, V _{GS} = -4 V/15 V		
Q_{gd}	Gate to Drain Charge		27		nC	I _D = 33.3 A	Fig. 12	
Qg	Total Gate Charge		94			Per IEC60747-8-4 pg 21		



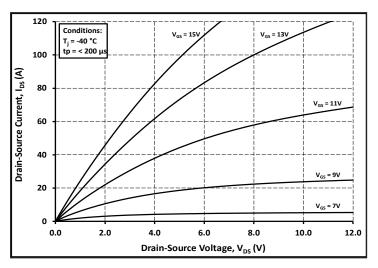
Reverse Diode Characteristics ($T_c = 25^{\circ}C$ unless otherwise specified)

Symbol	Parameter	Тур.	Max.	Unit	Test Conditions	Note
V_{SD}	Diada Famuard Valtaga	5.5		٧	V _{GS} = -4 V, I _{SD} = 20 A, T _J = 25°C	Fig. 8,
V _{SD} Diode Forward Voltage	4.5		٧	V _{GS} = -4 V, I _{SD} = 20 A, T _J = 150°C		
Is	Continuous Diode Forward Current		44	Α	V _{GS} = -4 V, T _C = 25°C	
S, pulse	Diode pulse Current		100	Α	V_{GS} = -4 V, pulse width t_p limited by T_{jmax}	Note 1
t _{rr}	Reverse Recover time	11		ns		
Q_{rr}	Reverse Recovery Charge	323		nC	$V_{GS} = -4 \text{ V, } I_{SD} = 33.3 \text{ A, V}_{R} = 800 \text{ V}$ dif/dt = 9890 A/µs	
I _{rrm}	Peak Reverse Recovery Current	52		Α		
t _{rr}	Reverse Recover time	17		ns		
Q _{rr}	Reverse Recovery Charge	150		nC	V _{GS} = -4 V, I _{SD} = 33.3 A, V _R = 800 V dif/dt = 1815 A/μs	Note 1
I _{rrm}	Peak Reverse Recovery Current	16		А	·	

Thermal Characteristics

Symbol	Parameter	Тур.	Unit	Test Conditions	Note
R _{θJC}	Thermal Resistance from Junction to Case	0.46			F: 04
R _{θJA}	Thermal Resistance From Junction to Ambient	40	°C/W		Fig. 21





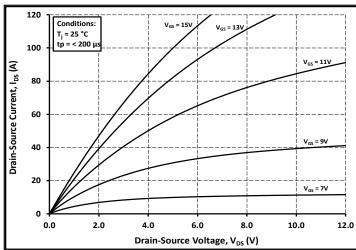
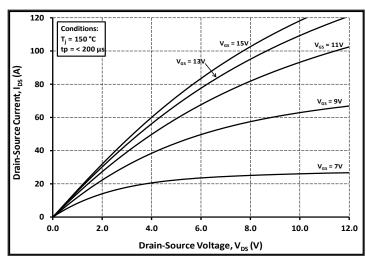


Figure 1. Output Characteristics T_J = -40 °C





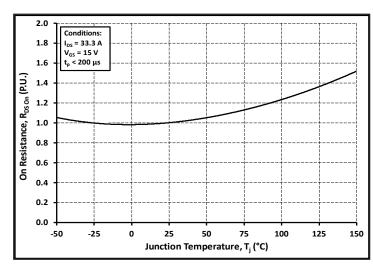
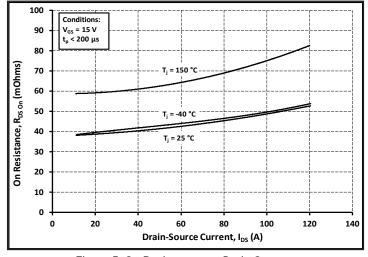


Figure 3. Output Characteristics T_J = 150 °C

Figure 4. Normalized On-Resistance vs. Temperature



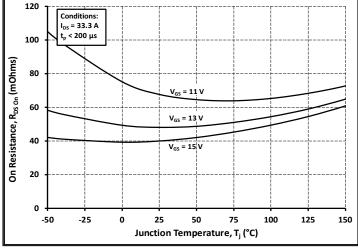
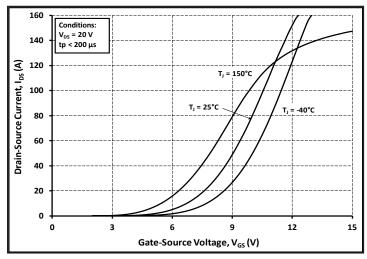


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

Figure 6. On-Resistance vs. Temperature For Various Gate Voltage





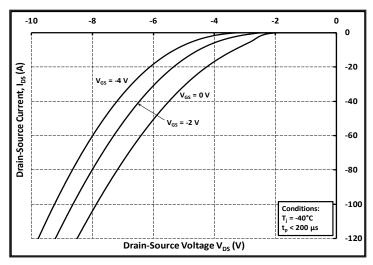
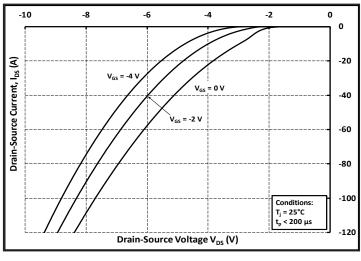


Figure 7. Transfer Characteristic for Various Junction Temperatures





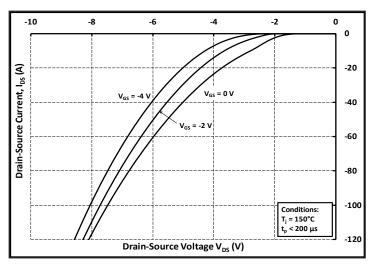
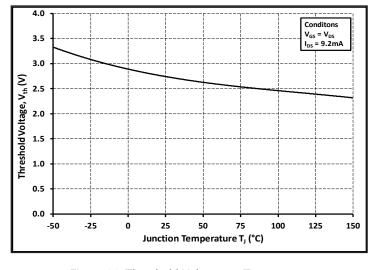


Figure 9. Body Diode Characteristic at 25 °C

Figure 10. Body Diode Characteristic at 150 °C



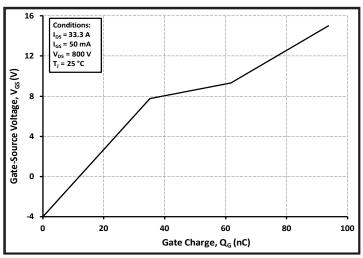
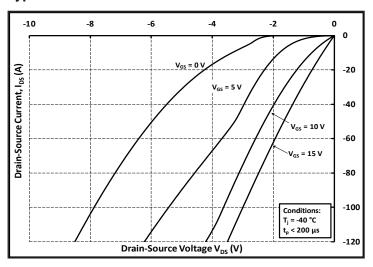


Figure 11. Threshold Voltage vs. Temperature

Figure 12. Gate Charge Characteristics





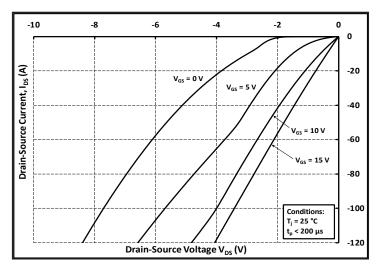


Figure 13. 3rd Quadrant Characteristic at -40 °C

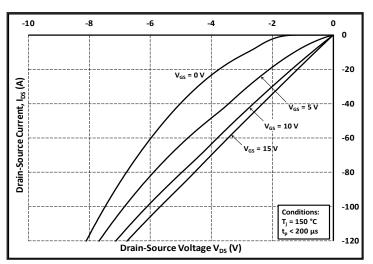


Figure 14. 3rd Quadrant Characteristic at 25 °C

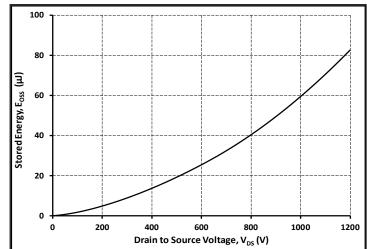


Figure 15. 3rd Quadrant Characteristic at 150 °C

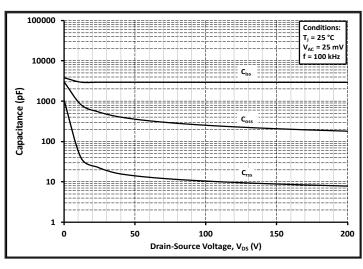


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

Figure 16. Output Capacitor Stored Energy

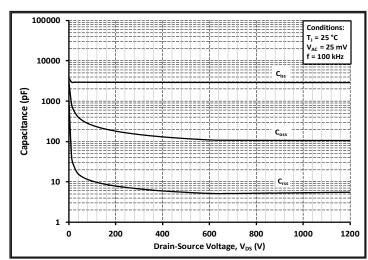
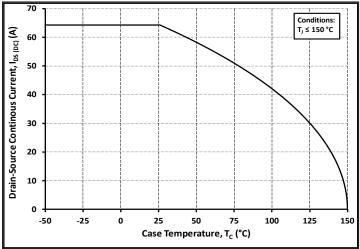


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1200V)





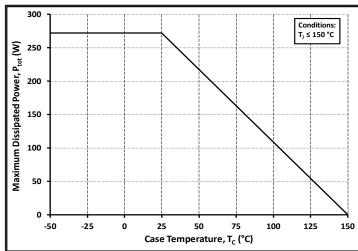
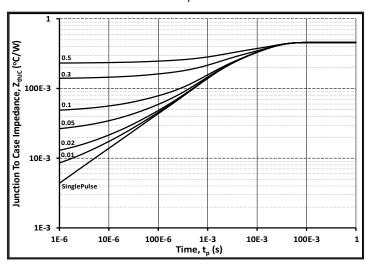


Figure 19. Continuous Drain Current Derating vs.

Case Temperature





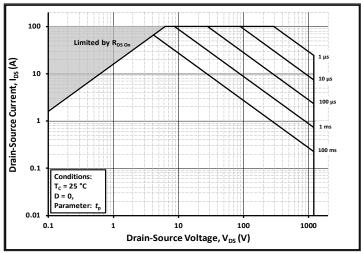
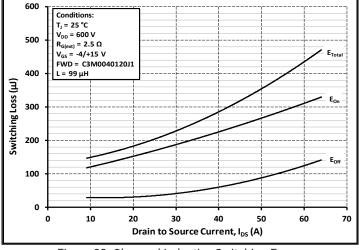


Figure 21. Transient Thermal Impedance (Junction - Case)

Figure 22. Safe Operating Area



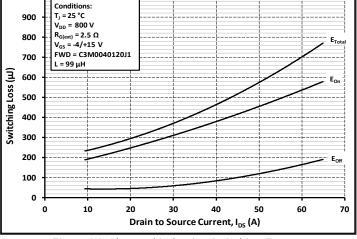
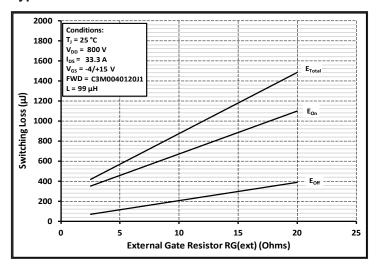


Figure 23. Clamped Inductive Switching Energy vs. Drain Current ($V_{DD} = 600V$)

Figure 24. Clamped Inductive Switching Energy vs. Drain Current (V_{DD} = 800V)

1000





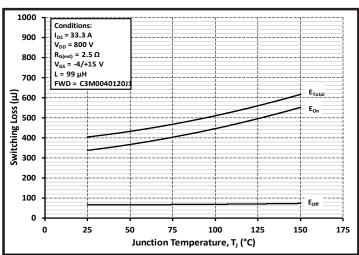


Figure 25. Clamped Inductive Switching Energy vs. $R_{G(ext)}$

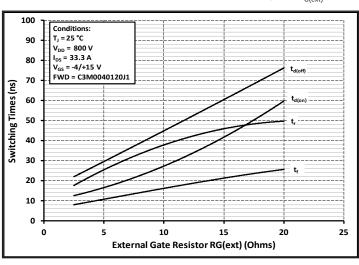


Figure 26. Clamped Inductive Switching Energy vs.
Temperature

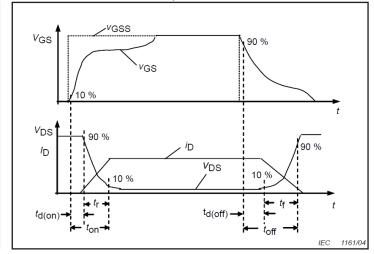


Figure 27. Switching Times vs. R_{G(ext)}

Figure 28. Switching Times Definition



Test Circuit Schematic

Rev. 0, October 2021

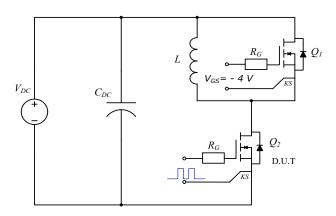


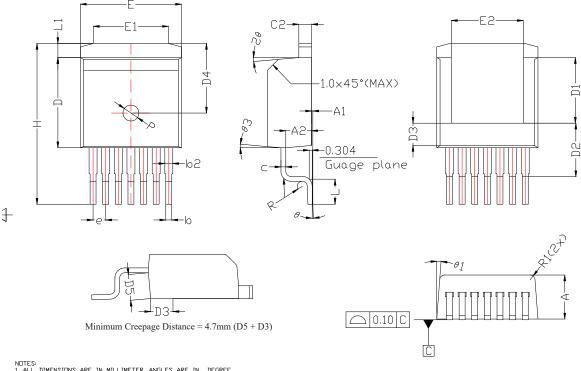
Figure 28. Clamped Inductive Switching Waveform Test Circuit

Note (3): Turn-off and Turn-on switching energy and timing values measured using SiC MOSFET Body Diode as shown above.



Package Dimensions

TO-263-7L XL



DIM	MIN	MAX	TYP			
D	9.025	9.125	9.075			
E	10.13	10.23	10.18			
Α	4.30	4.57	4.435			
Н	15.043	17.313	16.178			
D1	6.50	6.70	6.60			
E1	6.50	8.60	7.55			
D2	5.39 REF.					
E2	6.778	7.665	7.223			
D3	2.148		2.248			
D4	7	.00 RE	F.			
D5	2.555		2.605			
A1	0	0.25	0.125			
A2	2.	2.595 REF.				
е	1.	27 TY	Ρ.			
L	2.324	2.70	2.512			
b	0.50	0.70	0.60			
L1	0.968	1.868	1.418			
b2	0.60	1.00	0.80			
C5	1.17	1.37	1.27			
C	0.281	0.481	0.381			
l R	0.506 REF.					
- 13	0.0	JUB KE	<u>.</u> f.			
R1		.50 RE				
_	0 ø	.50 RE 1.60 R	F. EF.			
R1	0°	.50 RE 1.60 R 8°	F.			
R1 P θ	0° 0° 4.5°	.50 RE 1.60 R 8° 5.5°	F. EF.			
R1 P θ	0°	.50 RE 1.60 R 8°	F. EF. 4°			

NOTES:

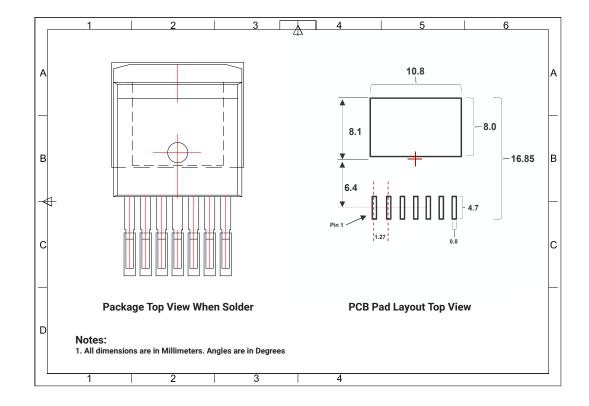
1. ALL DIMENSIONS ARE IN MILLIMETER, ANGLES ARE IN DEGREE.

2. DIMENSION 'D' DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSIONS. INTERLEAD FLASH SHALL NOT EXCEED 0.50 MM PER SIDE. DIMENSION 'E' DOES NOT INCLUDE MOLD FLASH, GATE BURRS,THE CATE BURRS SHALL NOT EXCEED 0.30MM

3. THE PACKAGE TIP MAY BE SMALLER THAN THE PACKGE BOTOM DIMENSIONS D AND E ARE DETERMINED AT THE DUTERMOST EXTERNES OF THE PLASTIC BODY EXCLUSIVE OF MOLD FLASH, TIE BAR BURRS, GATE BURRS AND INTERLEAD FLASH,BUT INCLUDING ANY MISMATCH BETWEEN THE TOP AND BOTTOM OF THE PLASTIC BODY.

4. "62" DIMENSION DON'T INCLUDE DAMBAR PROTRUSION.

5. THE VOID SHOULD BE CONTROL WITHIN 0.25MM.





Notes

This document and the information contained herein are subject to change without notice. Any such change shall be evidenced by the publication of an updated version of this document by Cree. No communication from any employee or agent of Cree or any third party shall effect an amendment or modification of this document. No responsibility is assumed by Cree for any infringement of patents or other rights of third parties which may result from use of the information contained herein. No license is granted by implication or otherwise under any patent or patent rights of Cree.

Not withstanding any application-specific information, guidance, assistance, or support that Cree may provide, the buyer of this product is solely responsible for determining the suitability of this product for the buyer's purposes, including without limitation for use in the applications identified in the next bullet point, and for the compliance of the buyers' products, including those that incorporate this product, with all applicable legal, regulatory, and safety-related requirements.

This product has not been designed or tested for use in, and is not intended for use in, applications in which failure of the product would reasonably be expected to cause death, personal injury, or property damage, including but not limited to equipment implanted into the human body, life-support machines, cardiac defibrillators, and similar emergency medical equipment, aircraft navigation, communication, and control systems, aircraft power and propulsion systems, air traffic control systems, and equipment used in the planning, construction, maintenance, or operation of nuclear facilities.

RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS2), as implemented January 2, 2013. RoHS Declarations for this product can be obtained from your Cree representative or from the Product Documentation sections of www.cree.com.

REACh Compliance

REACh substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact your Cree representative to ensure you get the most up-to-date REACh SVHC Declaration. REACh banned substance information (REACh Article 67) is also available upon request.

For more information please contact: 4600 Silicon Drive Durham, NC 27703 USA Tel: +1.919.313.5300 www.wolfspeed.com/power